

FDP6644/FDB6644

30V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

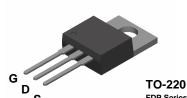
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $RDS_{(\text{ON})}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

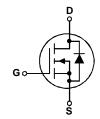
TO-263AB

- 50 A, 30 V. $R_{DS(ON)} = 8.5 \ m\Omega \ @ \ V_{GS} = 10 \ V$ $R_{DS(ON)} = 10.5 \ m\Omega \ @ \ V_{GS} = 4.5 \ V$
- Low gate charge (27 nC typical)
- · Fast switching speed
- High performance trench technology for extremely low $R_{\mbox{\scriptsize DS(ON)}}$
- 175°C maximum junction temperature rating



Absolute Maximum Ratings





FDP Series FDB Series

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		± 16	V
I _D	Drain Current - Continuous	(Note 1)	50	A
	– Pulsed	(Note 1)	150	A
P_D	Total Power Dissipation @ T _C = 25°C		83	W
	Derate above 25°C		0.55	W/°C
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-65 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDB6644	FDB6644	13"	24mm	800 units
FDP6644	FDP6644	Tube	n/a	45

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	ource Avalanche Ratings (Note	1)	I	I	I	
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 15 \text{ V}, \qquad I_{D} = 25 \text{ A}$			240	mJ
I _{AR}	Maximum Drain-Source Avalanche Current				25	Α
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C		26		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 16 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	NA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -16 \text{ V}, V_{DS} = 0 \text{ V}$			-100	NA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.5	3	V
<u>ΔV_{GS(th)}</u> ΔT _J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to $25^{\circ}C$		- 5		mV/°C
R _{DS(on)}	Static Drain-Source	$V_{GS} = 10 \text{ V}, \qquad I_{D} = 25 \text{A}$		6.4	8.5	mΩ
	On–Resistance	$V_{GS} = 4.5 \text{ V}, \qquad I_{D} = 25 \text{ A}$		7.3	10.5	
		V _{GS} = 10 V, I _D = 25 A, T _J =125°C		9.3	15	
I _{D(on)}	On–State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	60			A
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 25 \text{ A}$		98		S
	Characteristics		1	1	1	
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		3068		pF
Coss	Output Capacitance	f = 1.0 MHz		513		pF
C _{rss}	Reverse Transfer Capacitance			196		pF
Switchin	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		12.5	22.5	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		8	16	ns
$t_{d(off)}$	Turn-Off Delay Time			54	86	ns
t _f	Turn-Off Fall Time			14	26	ns
Q_g	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 25 \text{ A},$		27	38	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$		9		nC
Q_{gd}	Gate-Drain Charge			7		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	Diode Forward Current			50	Α
V _{SD}	Drain–Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 25 A (Note 2)		0.8	1.3	V

Notes:

^{1.} Calculated continuous current based on maximum allowable junction temperature. Actual maximum continuous current limited by package constraints to 75A.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics

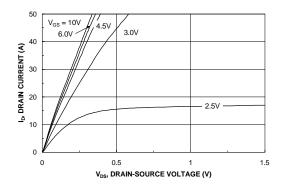


Figure 1. On-Region Characteristics.

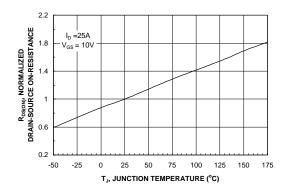


Figure 3. On-Resistance Variation with Temperature.

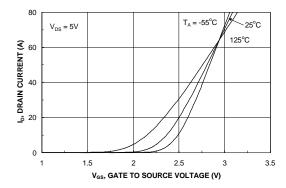


Figure 5. Transfer Characteristics.

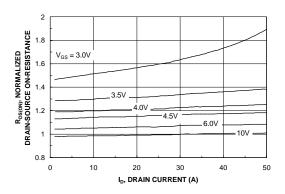


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

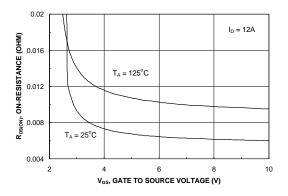


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

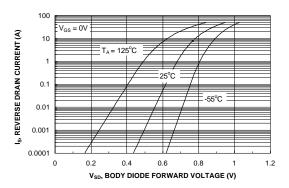
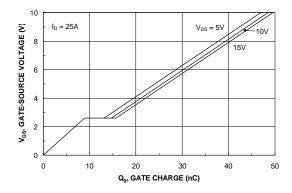


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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Typical Characteristics



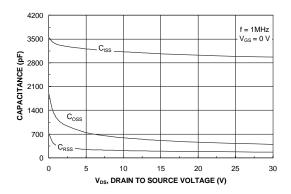
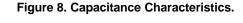
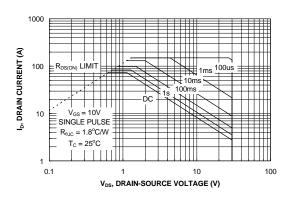


Figure 7. Gate Charge Characteristics.





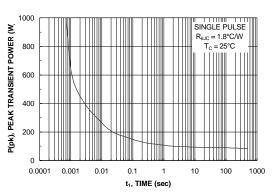


Figure 9. Maximum Safe Operating Area.



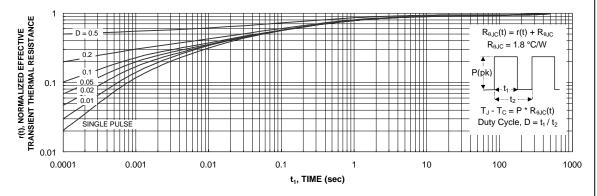


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1. Transient thermal response will change depending on the circuit board design.

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